


<b>Search Notes</b>  	<b>Application/Control No.</b>  10573492	<b>Applicant(s)/Patent Under Reexamination</b>  NANIWAE, KOICHI
	<b>Examiner</b>  ERIC W JONES	<b>Art Unit</b>  2892

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
438	689	8/21/2008	EJ

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Author search	3/17/2008	EJ
Key word search	8/21/2008	EJ
Key word search	3/24/2009	EJ
Key word search	3/25/2009	EJ
Key word search	3/26/2009	EJ
Discussed case with Thao Le	3/25/2009	EJ

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

/ERIC W JONES/ Examiner.Art Unit 2892	
--	--